

## 40V,互补高密度沟道 MOSFET

### Features

- N-MOS

$V_{DS} = 40V$ ,  $I_D = 9A$

$R_{DS(on)Typ} = 20m\Omega @ V_{GS} = 10V$

$R_{DS(on)Typ} = 23m\Omega @ V_{GS} = 4.5V$

- P-MOS

$V_{DS} = -40V$ ,  $I_D = -15A$

$R_{DS(on)Typ} = 30m\Omega @ V_{GS} = -10V$

$R_{DS(on)Typ} = 41m\Omega @ V_{GS} = -4.5V$

- Very Low On-resistance  $R_{DS(ON)}$

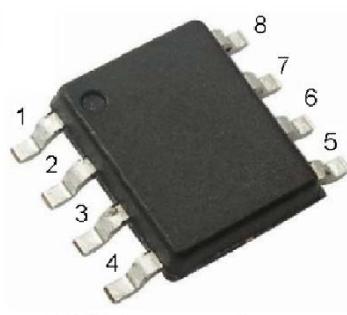
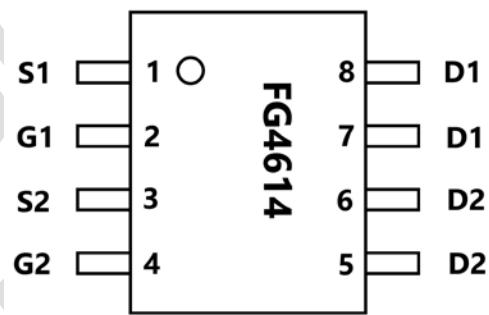
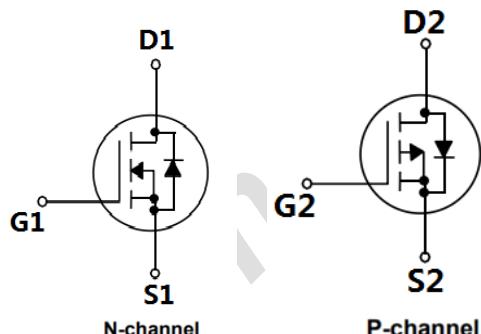
- Low Crss

- Fast switching

- Improved dv/dt capability

### Application

- PWM Application
- Load Switch
- Power Module



SOP-8 top view

### Mechanical Data

|   | NMOS                       | PMOS                       |
|---|----------------------------|----------------------------|
| Nominal Back Metal Composition,Thickness  | Ti-Ni-Ag,(1kA°-2kA°-10kA°) | Ti-Ni-Ag,(1kA°-2kA°-10kA°) |
| Nominal Front Metal Composition,Thickness | AlCU(4μm)                  | ALCU(4um)                  |
| Wafer Diameter                            | 200mm, with 010 notch      | 300 mm, with 010 notch     |
| Wafer Thickness                           | 150μm                      | 100 um+-10um               |
| Scribe line width                         | 60μm                       | 60μm                       |
| Passivation                               | USG+SiN                    | TEOS4K+SiN8K               |

## N-MOS Key Electrical Characteristics

| Parameter            | Description                          | Min.                               | Typ. | Max.      | Unit      | Test Condition                    |
|----------------------|--------------------------------------|------------------------------------|------|-----------|-----------|-----------------------------------|
| $V_{(BR)DSS}$        | Drain-to-Source Breakdown Voltage    | 40                                 | 47   | --        | V         | $V_{GS} = 0V, I_D = 250\mu A$     |
| $I_{D(Device\ Ref)}$ | Continuous Drain Current             | --                                 | --   | 9         | A         | $T_C = 25^\circ C$                |
| $R_{DS(on)}(CP)$     | Static Drain-to-Source On-Resistance | --                                 | 17   | 21        | $m\Omega$ | $V_{GS} = 10V, I_D = 1.0A$        |
|                      |                                      | --                                 | 20   | 38        | $m\Omega$ | $V_{GS} = 4.5V, I_D = 1.0A$       |
| $R_{DS(on)}(FT)$     | Static Drain-to-Source On-Resistance | --                                 | 20   | 26        | $m\Omega$ | $V_{GS} = 10V, I_D = 4A$          |
|                      |                                      | --                                 | 23   | 36        | $m\Omega$ | $V_{GS} = 4.5V, I_D = 3A$         |
| $V_{GS(th)}$         | Gate Threshold Voltage               | 1.0V                               | 1.3  | 1.9       | V         | $V_{DS} = V_{GS}, I_D = 250\mu A$ |
| $I_{DSS}$            | Drain-to-Source Leakage Current      | --                                 | --   | 1         | $\mu A$   | $V_{DS} = 40V, V_{GS} = 0V$       |
| $I_{GSS}$            | Gate-to-Source leakage Current       | --                                 | --   | $\pm 100$ | nA        | $V_{DS} = 0V, V_{GS} = \pm 20V$   |
| $T_J, T_{STG}$       | Operating and Storage Temperature    | $-55^\circ C$ to $150^\circ C$ Max |      |           |           |                                   |

## P-MOS Key Electrical Characteristics

| Parameter            | Description                          | Min. | Typ. | Max.      | Unit      | Test Condition                    |
|----------------------|--------------------------------------|------|------|-----------|-----------|-----------------------------------|
| $V_{(BR)DSS}$        | Drain-to-Source Breakdown Voltage    | -40  | -45  | --        | V         | $V_{GS} = 0V, I_D = -250\mu A$    |
| $I_{D(Device\ Ref)}$ | Continuous Drain Current             | --   | --   | -15       | A         | $T_C = 25^\circ C$                |
| $R_{DS(on)}(CP)$     | Static Drain-to-Source On-Resistance | --   | 28.5 | 34.5      | $m\Omega$ | $V_{GS} = -10V, I_D = -1.0A$      |
|                      |                                      | --   | 39.5 | 51.5      | $m\Omega$ | $V_{GS} = -4.5V, I_D = -1.0A$     |
| $R_{DS(on)}(FT)$     | Static Drain-to-Source On-Resistance | --   | 30   | 40        | $m\Omega$ | $V_{GS} = -10V, I_D = -15A$       |
|                      |                                      | --   | 41   | 53        | $m\Omega$ | $V_{GS} = -4.5V, I_D = -10A$      |
| $V_{GS(th)}$         | Gate Threshold Voltage               | -1.0 | -1.7 | -2.5      | V         | $V_{DS} = V_{GS}, I_D = 250\mu A$ |
| $I_{DSS}$            | Drain-to-Source Leakage Current      | --   | --   | -1.0      | $\mu A$   | $V_{DS} = -40V, V_{GS} = 0V$      |
| $I_{GSS}$            | Gate-to-Source leakage Current       | --   | --   | $\pm 100$ | nA        | $V_{GS} = \pm 20V, V_{DS} = 0V$   |

## N-Channel Typical Characteristics

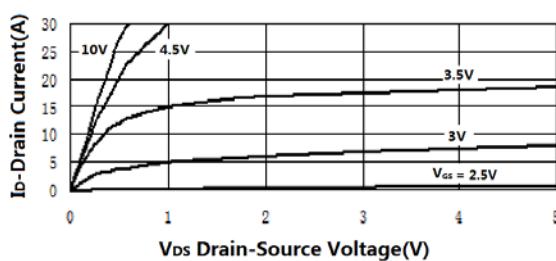


Fig.1 Typical Output Characteristics

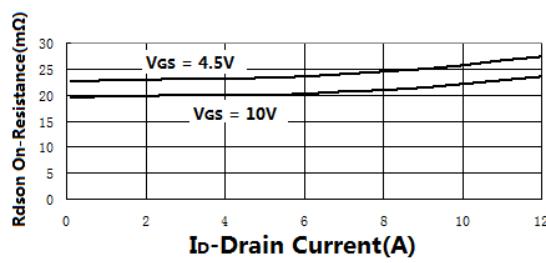


Fig.2 Drain-Source On-Resistance

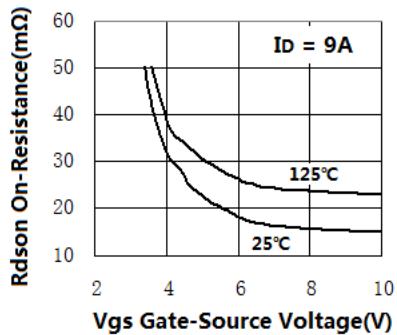
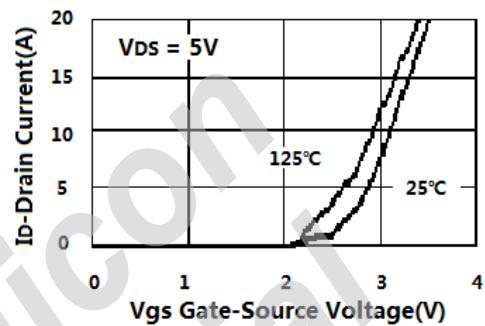
Fig.3  $R_{dson}$  vs  $V_{gs}$ 

Fig.4 Transfer Characteristics

## P-Channel Typical Characteristics

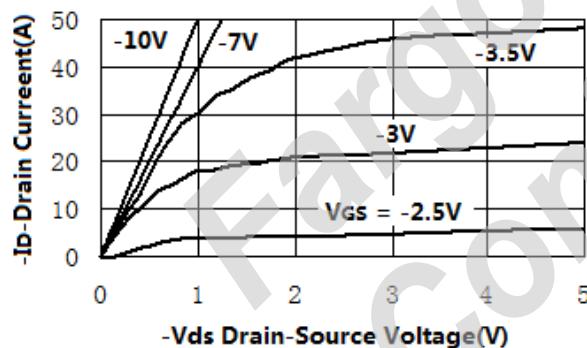


Fig.1 Typical Output Characteristics

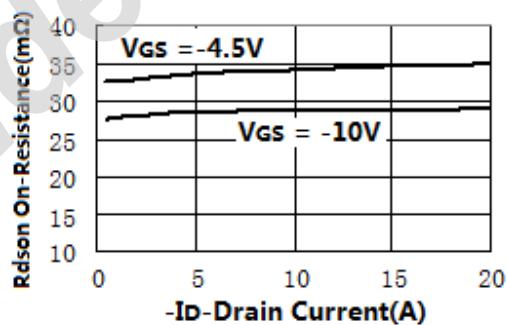
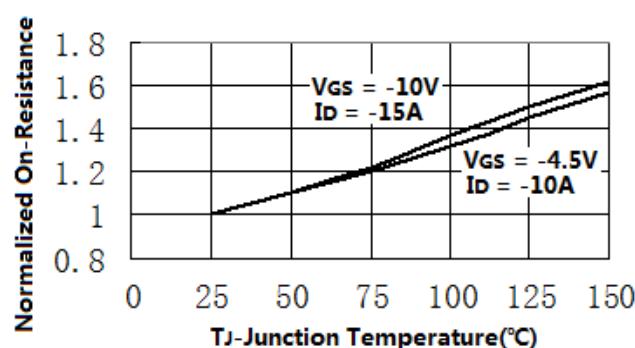
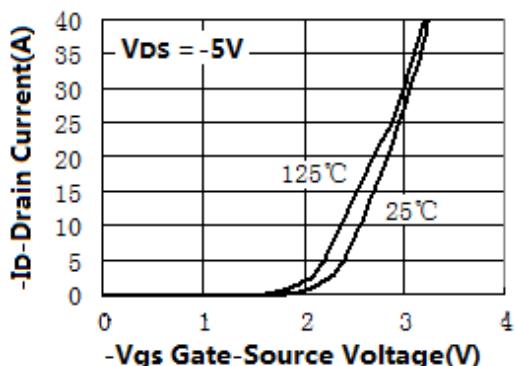
Fig.2  $R_{dson}$ -Drain CurrentFig.3  $R_{dson}$ -Junction Temperature

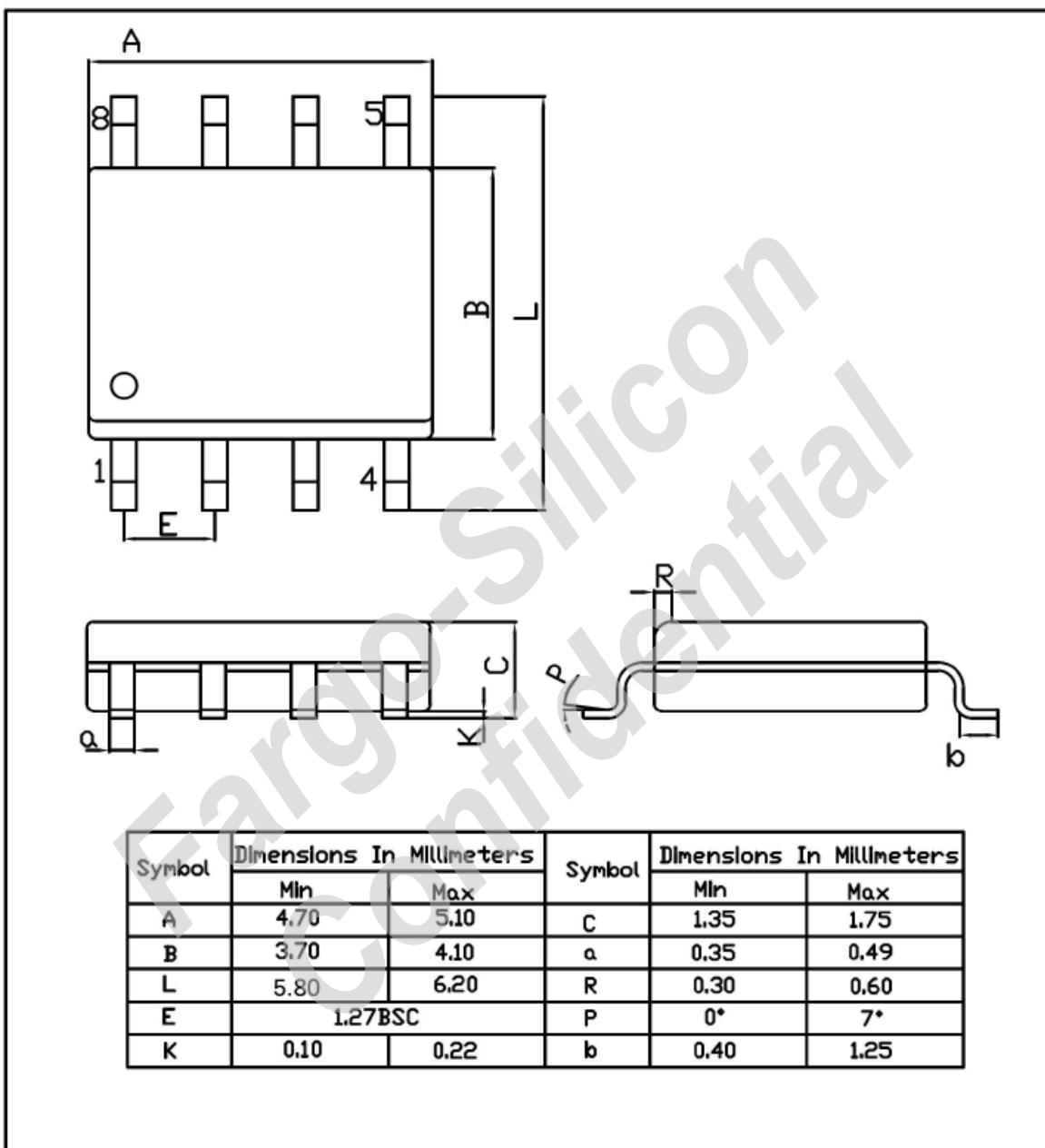
Fig.4 Transfer Characteristics

## SOP-8 封装信息

**SOP-8 外形尺寸图**

SOP-8

Unit:mm



## 联系方式

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